

Statistical Classification with Empirically Observed Statistics

Mahdi Haghifam*

Joint work with

Vincent Y. F. Tan[†] and Ashish Khisti*

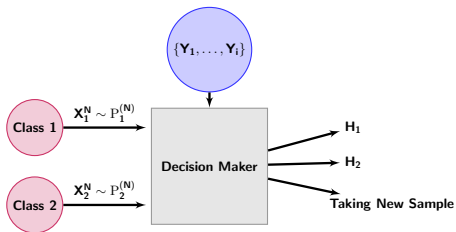
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Outline

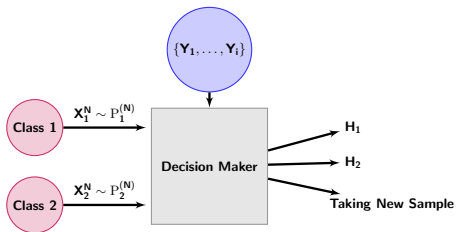
- 1 Problem Definition
- 2 Prior Work
- 3 Main Results
- 4 Multiple classes
- 5 Summary and Future Work

Problem Definition



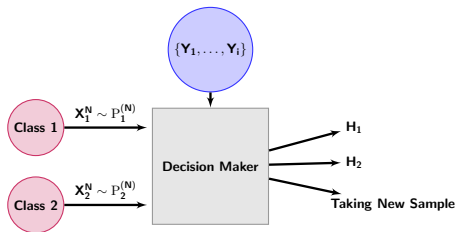
- Two training sequences: $X_1^N \sim P_1^{(N)}$ and $X_2^N \sim P_2^{(N)}$.

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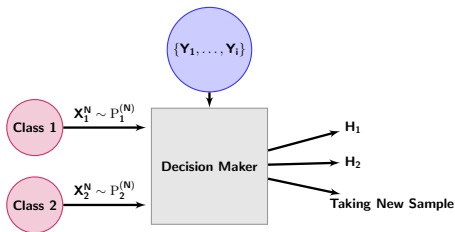
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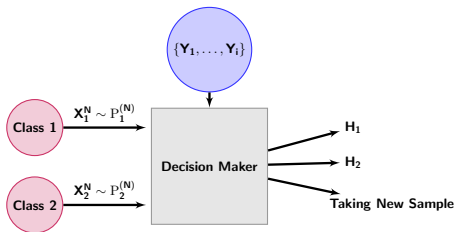
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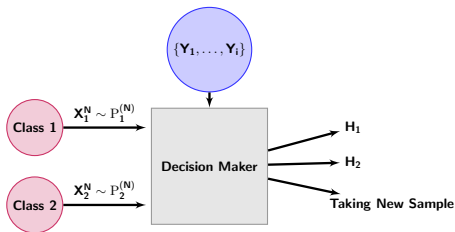
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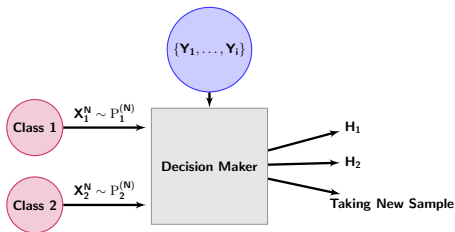
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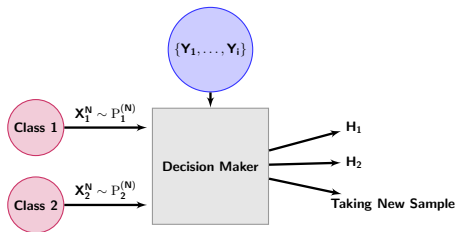
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 - 1 Declare H_1
 - 2 Declare H_2
 - 3 Continue drawing a new test sample.

Problem Definition (cont'd)

Definition (Test)

A test is a pair $\Phi = (T, d)$ where

- $T \in \mathbb{N}$ is a stopping time.
- $d : (X_1^N, X_2^N, Y^T) \rightarrow \{1, 2\}$ is the terminal decision rule.

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Definition (Error Probabilities)

For a test Φ , the error probability under the hypothesis H_i is defined as

$\mathbb{P}_\Phi(\mathcal{E} | H_i) = \mathbb{P}_\Phi(d \neq i | H_i)$. Note that \mathcal{E} and T are random variables depend on N i.e., the length of the training sequence.

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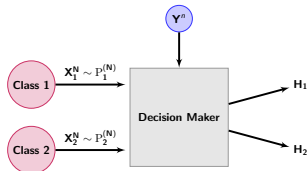
Definition (Error Exponents)

For a test Φ such that $\mathbb{P}_\Phi(\mathcal{E}|H_i) \rightarrow 0$ as $N \rightarrow \infty$, we define the error exponents as

$$E_i(\Phi) = \liminf_{N \rightarrow \infty} \frac{-\log \mathbb{P}_\Phi(\mathcal{E}|H_i)}{\mathbb{E}_\Phi[T|H_i]}$$

Prior Works

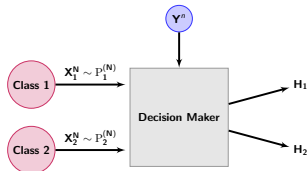
- Gutman (TIT 1989) setup:
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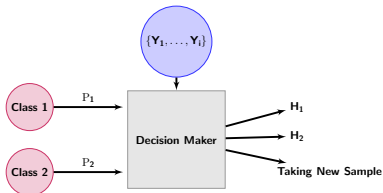
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- Sequential Hypothesis Testing (Wald 1945) :

- Distributions (P_1, P_2) are assumed to be **Known**.



Prior Works: More on Gutman's Results

- For any $\alpha \in \mathbb{R}_+$, define Generalized Jensen-Shannon Divergence as

$$\text{GJS}(P_1, P_2, \alpha) \triangleq \alpha \text{KL} \left(P_1 \parallel \frac{\alpha P_1 + P_2}{1 + \alpha} \right) + \text{KL} \left(P_2 \parallel \frac{\alpha P_1 + P_2}{1 + \alpha} \right)$$

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- Gutman's test $\phi_n^{(\text{Gut})}$ is

$$\phi_n^{(\text{Gut})} \triangleq \begin{cases} 2 & \text{if } \text{GJS} \left(\mathcal{T}_{X_1^N}, \mathcal{T}_{Y^n}, \alpha \right) \geq \lambda \\ 1 & \text{if } \text{GJS} \left(\mathcal{T}_{X_1^N}, \mathcal{T}_{Y^n}, \alpha \right) \leq \lambda \end{cases}.$$

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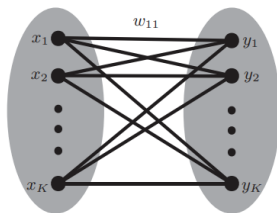
Our goal in this work is to propose a **sequential** version of Gutman's framework.

Other Related Works

- Second-order analysis [Zhou et al, 2018]: What happened if n and N in Gutman's setup are finite?

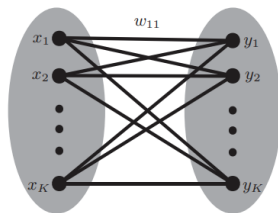
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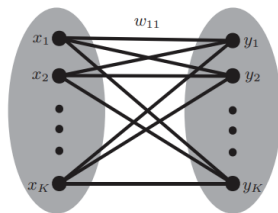
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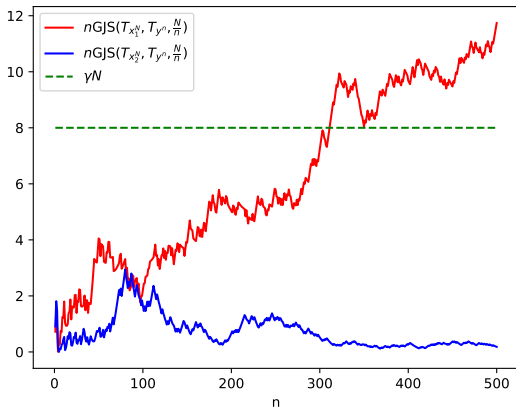
- Alphabet Size [Kelly et al 2013]: Assume the scenario that the alphabet size grows with length of training and test sequences \Rightarrow model for natural language \Rightarrow what is the largest possible growth rate?
- Closeness Testing [Acharya et al, 2012]. Given two sequences, we want to determine whether they are from the same distribution or not.

Main Results: Motivation

- Design $\{f_t^{(i)}\}_{t \in \mathbb{N}}$ for $i \in \{1, 2\}$.
- $f_t^{(i)} : \mathcal{X}^N \times \mathcal{X}^t \rightarrow \mathbb{R}$.
- $f_t^{(i)} \rightarrow$ measures whether the test sequence and training sequence i generated according to the same distribution or not.

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Main Results: Proposed Test

Proposed Test for the Sequential Setting

Let $\Phi_{\text{seq}} = (T_{\text{seq}}, d_{\text{seq}})$. Our proposed test consists of

$$T_{\text{seq}} = \inf \left\{ n \geq 1 : \exists i \in \{1, 2\} \text{ such that } n\text{GJS} \left(\mathcal{T}_{X_i^n}, \mathcal{T}_Y^n, \frac{N}{n} \right) \geq \gamma N \right\},$$

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$$d_{\text{seq}} = \begin{cases} 1 & \text{if } T_{\text{seq}}\text{GJS} \left(\mathcal{T}_{X_2^N}, \mathcal{T}_Y^{T_{\text{seq}}}, \frac{N}{T_{\text{seq}}} \right) \geq \gamma N, \\ 2 & \text{if } T_{\text{seq}}\text{GJS} \left(\mathcal{T}_{X_1^N}, \mathcal{T}_Y^{T_{\text{seq}}}, \frac{N}{T_{\text{seq}}} \right) \geq \gamma N. \end{cases}$$

Main Results: Achievable Error Exponent

Theorem(Achievable Error Exponent)

Fix pair $(P_1, P_2) \in \mathcal{P}(\mathcal{X})^2$. Then, the proposed test achieves

$$E_1(\Phi_{\text{seq}}) = \liminf_{N \rightarrow \infty} \frac{-\log \mathbb{P}_{\Phi_{\text{seq}}}(\mathcal{E} | H_1)}{\mathbb{E}_{\Phi_{\text{seq}}}[T_{\text{seq}} | H_1]} \geq \text{GJS}(P_2, P_1, \beta^*), \quad (1)$$

$$E_2(\Phi_{\text{seq}}) = \liminf_{N \rightarrow \infty} \frac{-\log \mathbb{P}_{\Phi_{\text{seq}}}(\mathcal{E} | H_2)}{\mathbb{E}_{\Phi_{\text{seq}}}[T_{\text{seq}} | H_2]} \geq \text{GJS}(P_1, P_2, \theta^*). \quad (2)$$

Here, in (1), β^* is the solution of $\text{GJS}(P_2, P_1, \beta^*) = \gamma\beta^*$. Similarly, θ^* in (2) is the solution of $\text{GJS}(P_1, P_2, \theta^*) = \gamma\theta^*$.

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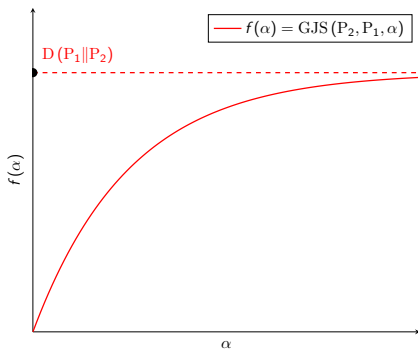
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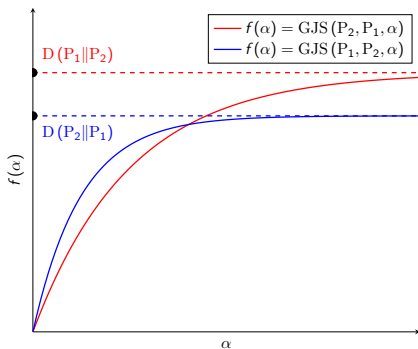
Theorem(Expected Value of the Stopping Time)

- $\mathbb{E}[T_{\text{seq}} | H_1] = \frac{N}{\beta^*} (1 + o_N(1))$
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Main Results: Discussion

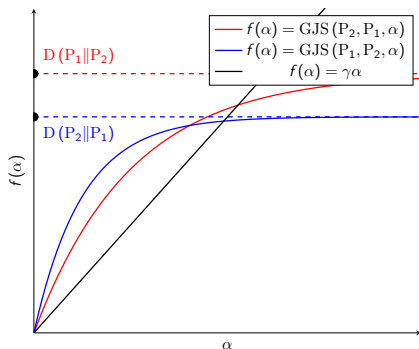


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- 1 Uniqueness of the intersections \rightarrow Concavity
- 2 When β^* and θ^* goes to infinity \rightarrow Number of training samples per a test sample tends to infinity for H_1 and $H_2 \rightarrow (D(P_1||P_2), D(P_2||P_1))$ is achievable \rightarrow Converse for Sequential Hypothesis Testing:

$$E_1(\Phi) \times E_2(\Phi) \leq D(P_1||P_2) \times D(P_2||P_1)$$

Comparison with Gutman's test: Empirical Results

- The performance metric is the minimum of type-I and type-II error exponents.

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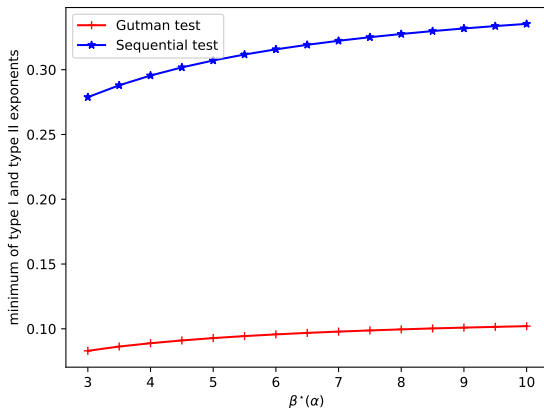
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- $\mathcal{X} = \{1, 2, 3, 4\}$, $P_1 = [0.25, 0.25, 0.25, 0.25]$, and $P_2 = [0.4, 0.5, 0.05, 0.05]$.
- # test samples under H_2 for $\Phi_{\text{seq}} =$ # test samples for Φ_{Gut} .

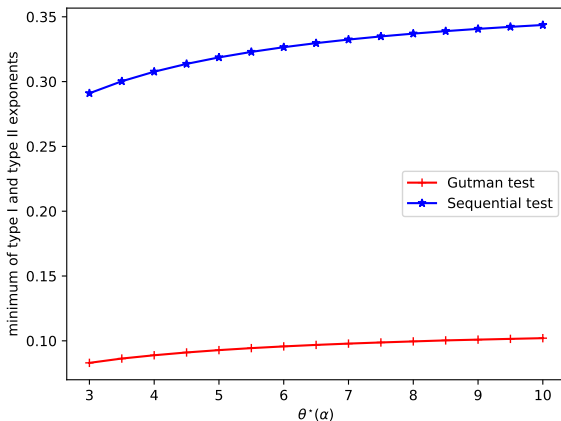
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- $\#$ test samples under H_2 for $\Phi_{\text{seq}} = \#$ test samples for Φ_{Gut} .



Comparison with Gutman's test: Empirical Results

- # test samples under H_1 for $\Phi_{\text{seq}} = \#$ test samples for Φ_{Gut} .



Comparison with Gutman's test: Theoretical Results

Bayesian Error Exponent

Define Bayesian error probability for test Φ as

$$\mathbb{P}_{\Phi}(\mathcal{E}) = \pi_1 \mathbb{P}_{\Phi}(\mathcal{E} | H_1) + \pi_2 \mathbb{P}_{\Phi}(\mathcal{E} | H_2)$$

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Let us assume each of both schemes, i.e., proposed and Gutman's tests, has two training sequence of length N , and we define the error exponent for the Bayesian scenario as

$$e_{\text{bayesian}}(\Phi) \triangleq \liminf_{N \rightarrow \infty} \frac{-\log \mathbb{P}_{\Phi}(\mathcal{E})}{N}$$

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$$e_{\text{bayesian}}(\Phi_{\text{seq}}) > e_{\text{bayesian}}(\Phi_{\text{Gut}})$$

Sequential Classification with Multiple classes

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Main Results: Proposed Test

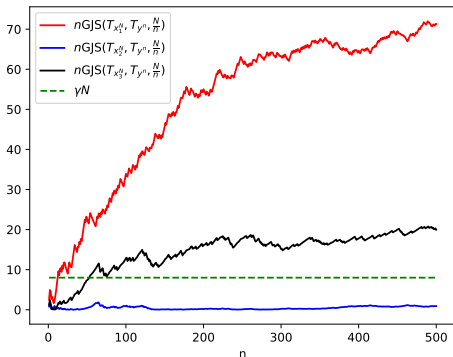
- Let $\Psi_n \triangleq \left\{ i \in \{1, \dots, M\} : \exists 1 \leq k \leq n \text{ such that } k\text{GJS} \left(\widehat{Q}_{X_i^N}, \widehat{Q}_{Y^k}, \frac{N}{k} \right) \geq \gamma N \right\}$.

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Main Results: Achievable Exponent

Theorem(Achievable Error Exponent)

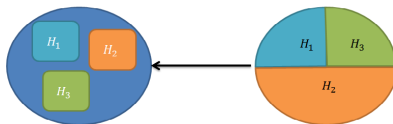
Fix $(P_1, \dots, P_M) \in \mathcal{P}(\mathcal{X})^M$. Then, the proposed test achieves

$$E_i(\Phi_{\text{seq}}^{(M)}) = \liminf_{N \rightarrow \infty} \frac{-\log \mathbb{P}_{\Phi_{\text{seq}}^{(M)}}(\mathcal{E} | H_i)}{\mathbb{E}_{\Phi_{\text{seq}}^{(M)}}[T_{\text{seq}} | H_i]} \geq \min_{j \in \{1, \dots, M\}, j \neq i} \text{GJS}(P_j, P_i, \beta_{i(j)}^*)$$

where $\text{GJS}(P_j, P_i, \beta_{i(j)}^*) = \gamma \beta_{i(j)}^*$ for $j \in \{1, \dots, M\}, j \neq i$.

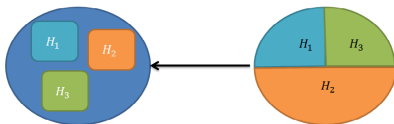
Comparison with Gutman's test: Multiple Class

- What is the **Rejection Region**?



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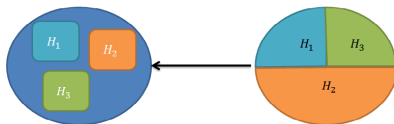
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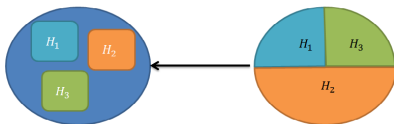
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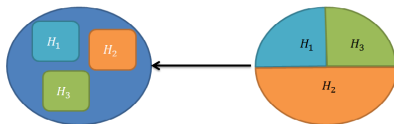


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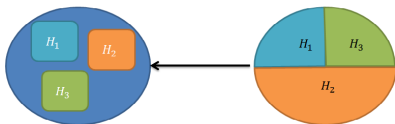


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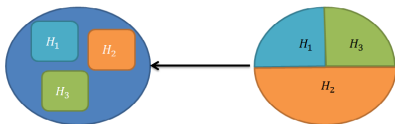
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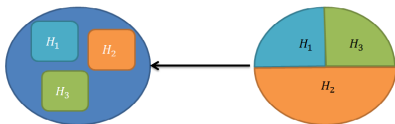
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What is the largest possible λ such that as n goes to infinity the rejection error probability tends to zero?

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Comparison with Gutman's test: Theoretical Results

Bayesian Error Exponent

Define Bayesian error probability for test Φ as

$$\mathbb{P}_\Phi(\mathcal{E}) = \sum_{i=1}^M \pi_i \mathbb{P}_\Phi(\mathcal{E} | H_i)$$

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Let us assume each of both schemes, i.e., proposed and Gutman's tests, has M training sequence of length N , and we define the error exponent for the Bayesian scenario as $e_{\text{bayesian}}(\Phi) \triangleq \liminf_{N \rightarrow \infty} \frac{-\log \mathbb{P}_{\Phi}(\mathcal{E})}{N}$

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$$e_{\text{bayesian}}\left(\Phi_{\text{seq}}^{(M)}\right) = e_{\text{bayesian}}\left(\Phi_{\text{Gut}}^{(M)}\right)$$

Thus, our test achieves the same Bayesian error exponent without having rejection region!

Summary and Future Work

- Summary
 - ① We extended the Gutman's framework for classification to the sequential setting.
 - ② We proposed a test for the problem.
 - ③ We showed that this test surpasses the Gutman's scheme in terms of the Bayesian error exponent.
- Future Works
 - ① Extension to the Markov Sources.
 - ② Converse Bound.

Thank You!